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(54) **ELECTRONIC CIRCUIT DEVICE**
INCLUDING METALLIC MEMBER HAVING
INSTALLATION MEMBERS

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H01L 23/10; H01L 23/04; B23K 31/02

(52) **U.S. Cl.** **257/704**; 257/713; 257/712;
257/710; 257/778; 257/737; 257/738; 257/685;
257/723; 257/777; 257/686; 257/784; 257/668;
257/675

(58) **Field of Search** 257/704, 707,
257/712, 713, 710, 778, 737, 738, 685,
686, 723, 777, 784, 668, 675

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(57) **ABSTRACT**

Bumps are formed on electrodes of semiconductor elements, and moreover, the semiconductor elements with the bumps are electrically connected to metallic members having installation members, whereby wiring lines are eliminated. Stray inductance and conduction resistance resulting from wiring lines can be reduced. A conventional dented connector and a projecting connector are eliminated by connecting the installation members to a second circuit board, thereby enabling an electronic circuit device of a power control system to be made compact.

6 Claims, 8 Drawing Sheets

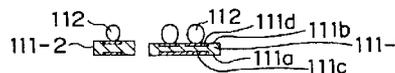
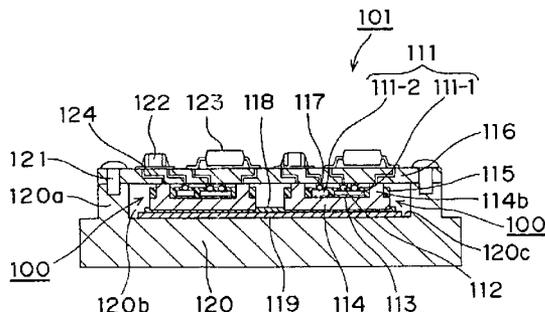


Fig. 1

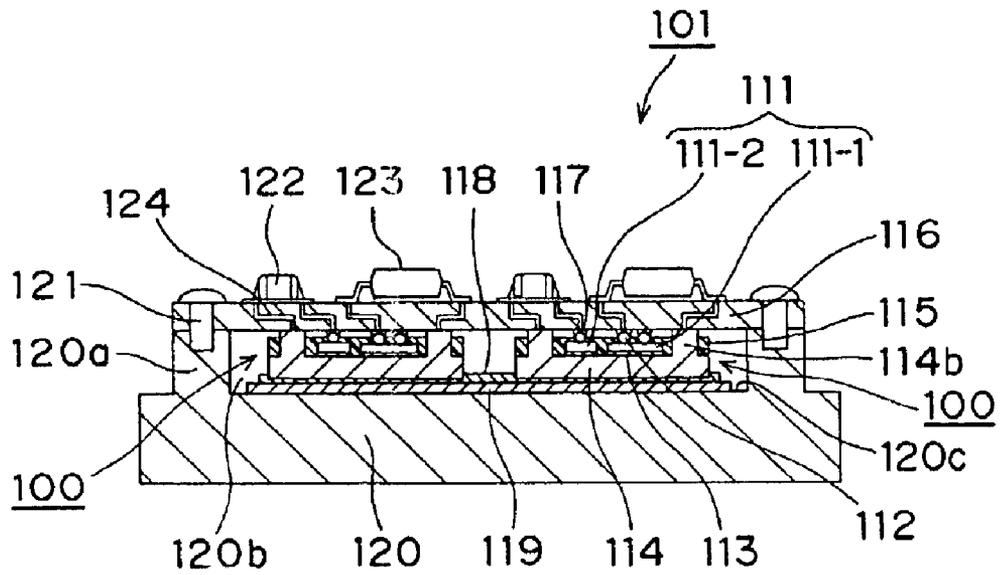


Fig. 2

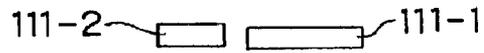


Fig. 3

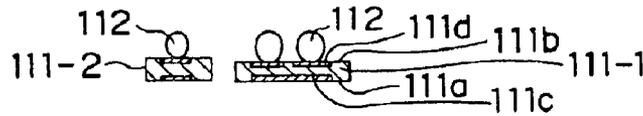


Fig. 4

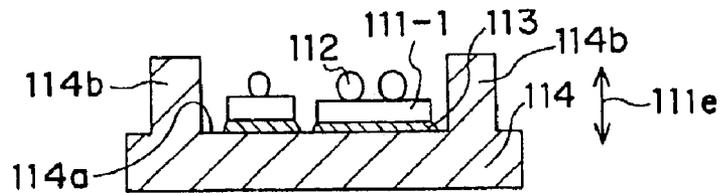


Fig. 5

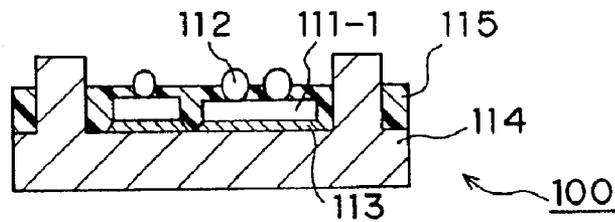


Fig. 6

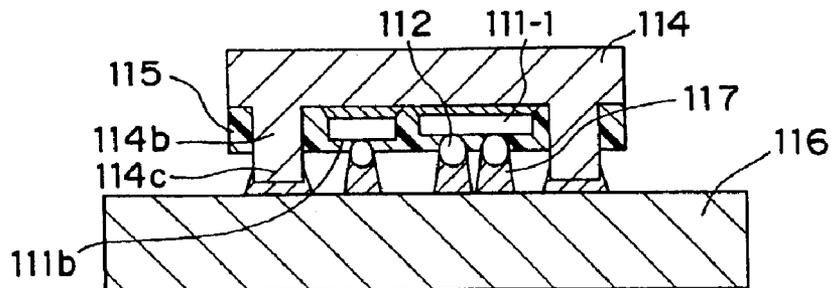
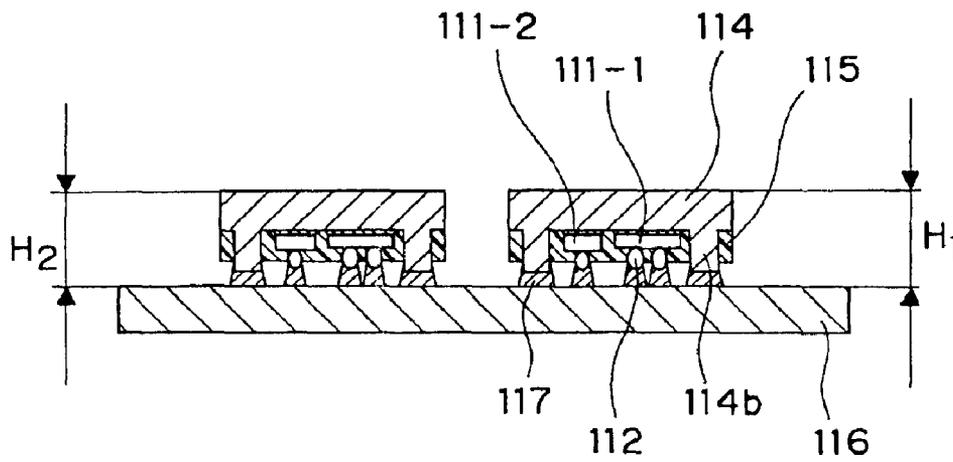


Fig. 7



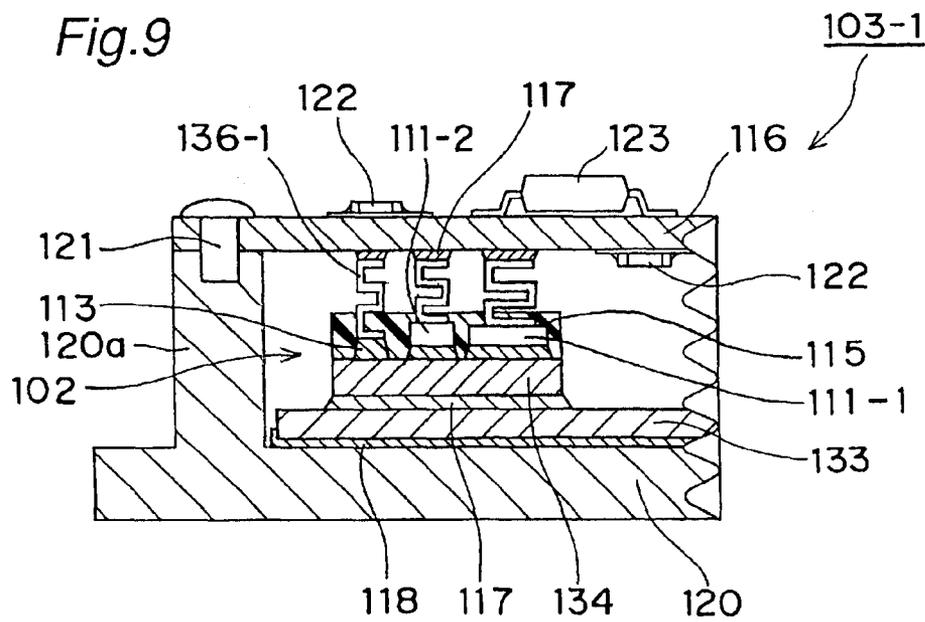
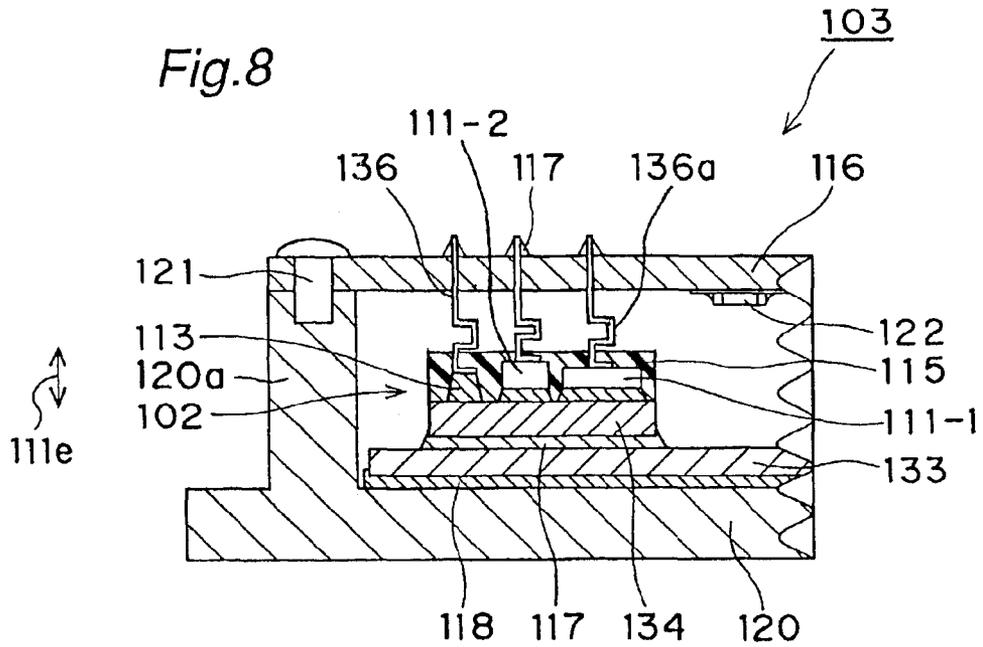


Fig. 10

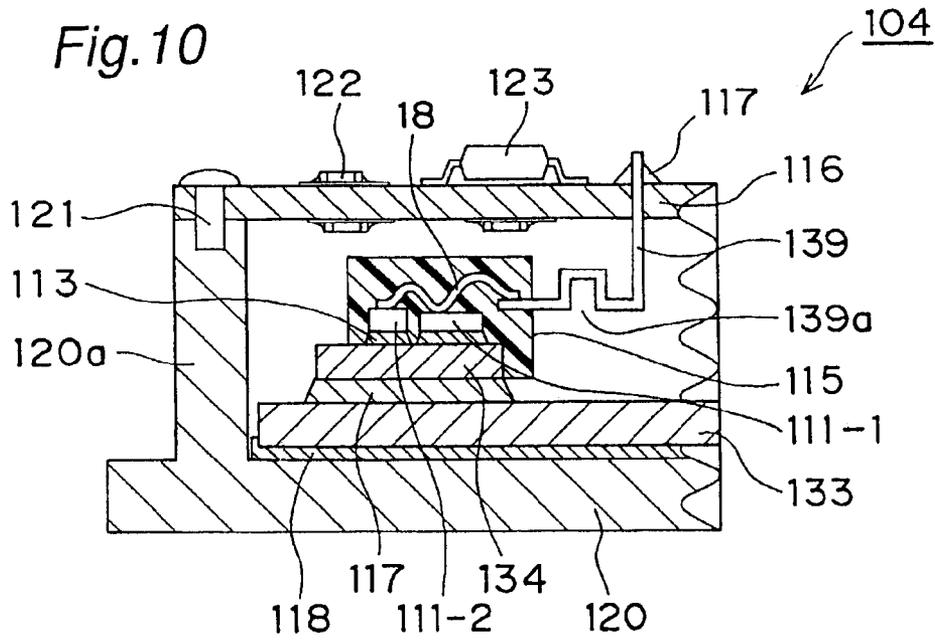
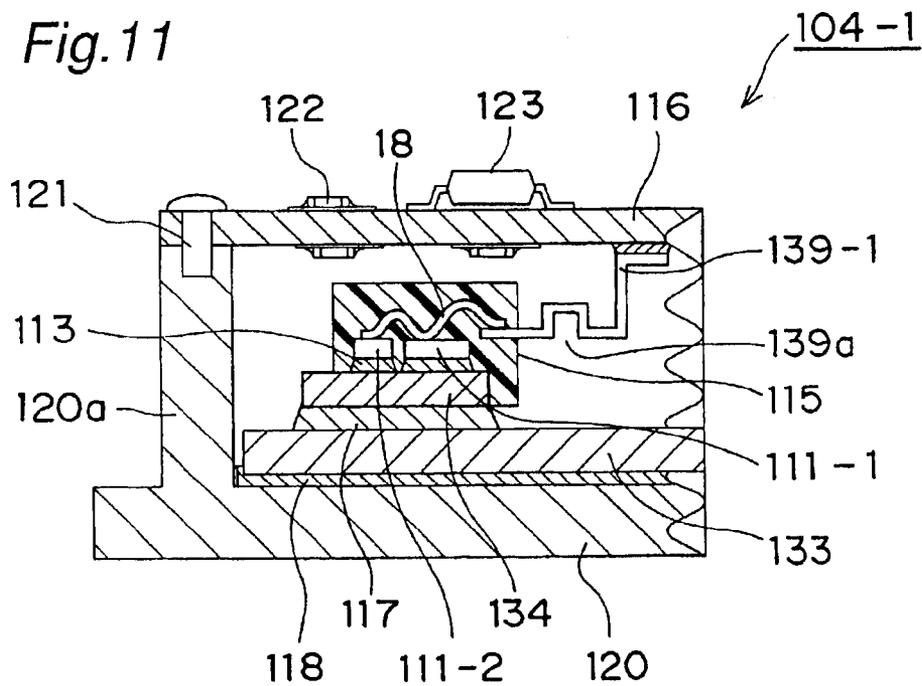
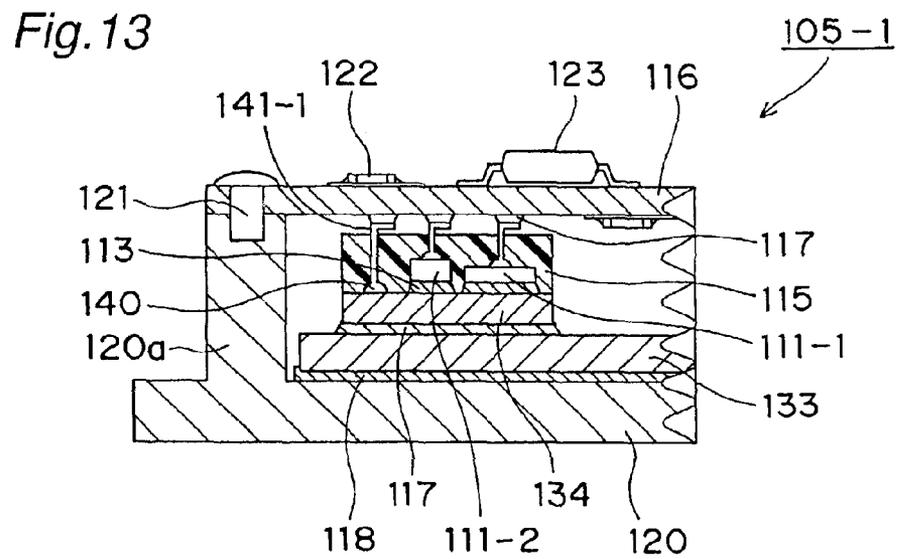
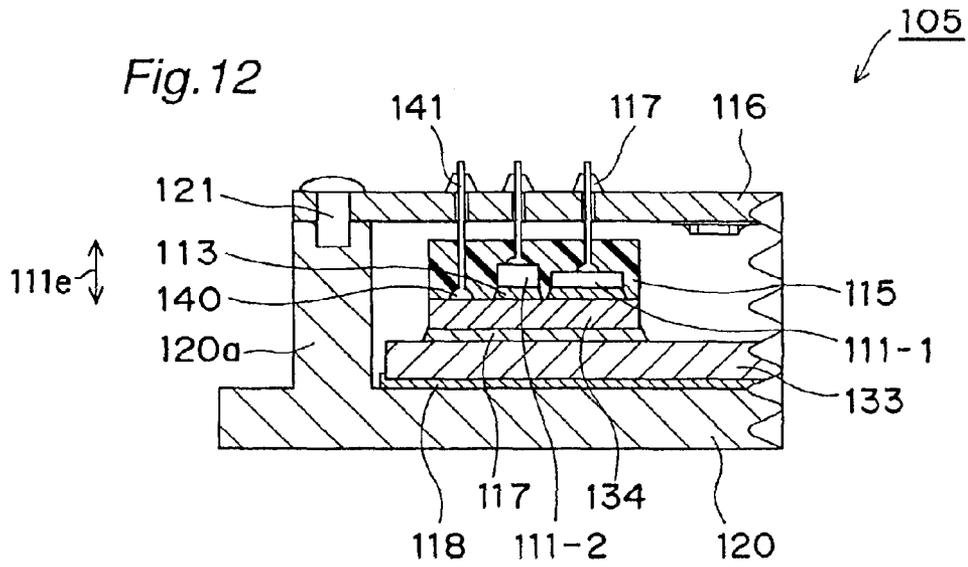


Fig. 11





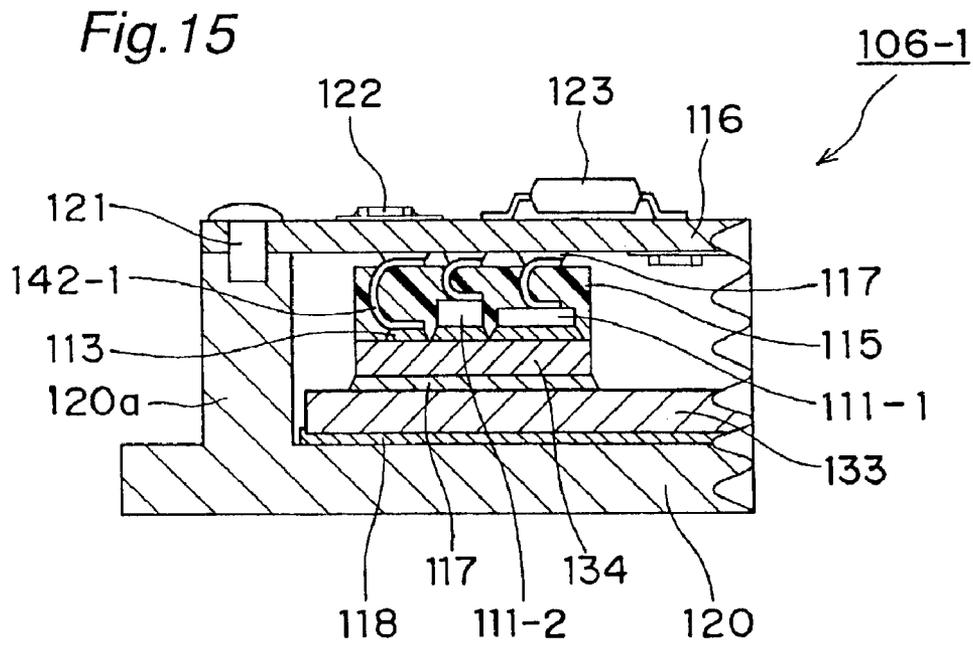
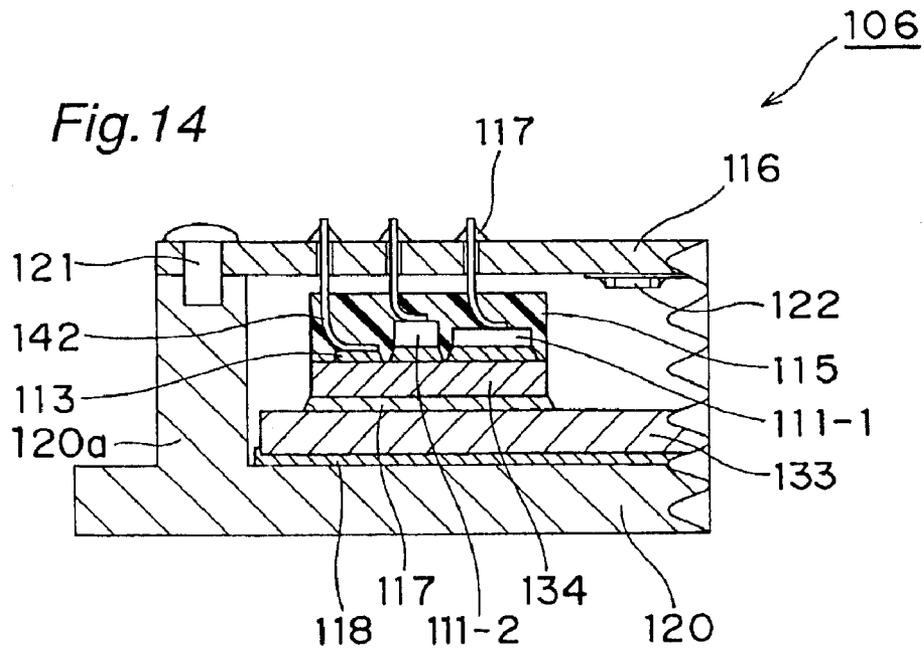
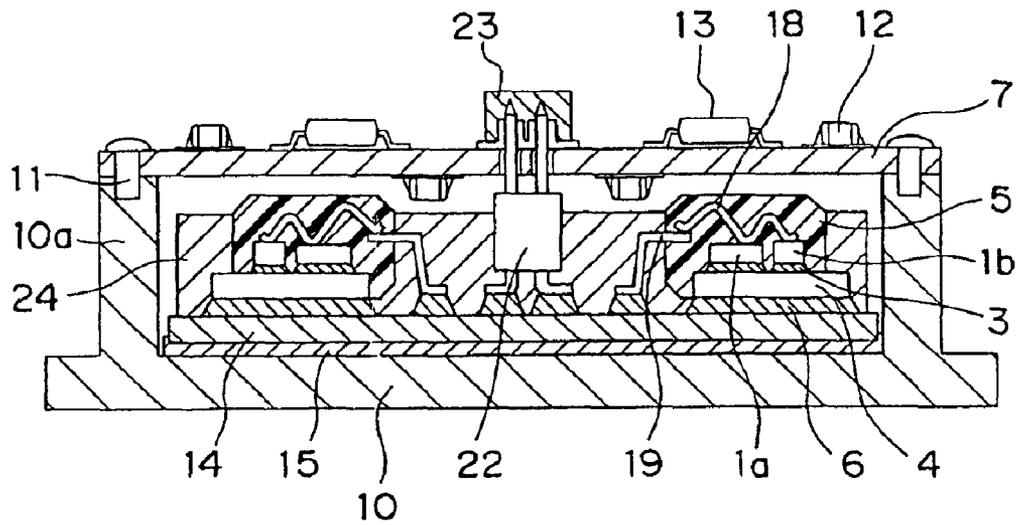


Fig. 16 PRIOR ART



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**ELECTRONIC CIRCUIT DEVICE
INCLUDING METALLIC MEMBER HAVING
INSTALLATION MEMBERS**

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TECHNICAL FIELD

The present invention relates to an electronic circuit device of a power control system using semiconductor elements such as IGBTs (Insulated Gate Bipolar Transistors), diodes and the like, for driving motors, and a method for manufacturing the electronic circuit device.

BACKGROUND ART

Lately, a working current in a motor driving device has increased in accordance with an enhancement in performance and function of electronic devices used in the motor driving device, thereby requiring semiconductors to be used to meet a high current. A motor driving device used conventionally is shown in FIG. 16. An example of this conventional motor driving device will be described below with reference to FIG. 16.

In FIG. 16, reference numerals respectively indicate: *1a* an IGBT; *1b* a diode; **3** a high temperature solder; **4** a metallic element; **5** a sealing resin; **6** a solder; **7** a circuit board; **10** a heat radiation plate; *10a* a projecting screw bed; **11** a screw; **12** a surface mounting electronic component (passive element); **13** a surface mounting electronic component (semiconductor element); **14** a metallic base circuit board; **15** a silicone grease; **18** a metallic wire; **19** a metallic lead; **22** a projecting connector; **23** a dented connector; and **24** an insulation resin.

A method for manufacturing this thus-constituted conventional motor driving device will be discussed hereinbelow.

Semiconductor components such as the IGBT *1a*, the diode *1b* and the like are connected by the high temperature solder **3** to metallic elements **4**. The IGBT *1a* and the diode *1b*, and these semiconductor components and metallic lead **19**, are electrically joined together with use of the metallic wire **18**. An aluminum wire or a gold wire is normally used as the metallic wire **18**. In using a metallic wire **18** formed of, e.g., aluminum, the metallic wire **18** is connected to a second electrode of one of these semiconductor components by performing wedge bonding of the aluminum wire. The second electrode is present opposite to a first electrode of this semiconductor component, which is joined to the metallic element **4**. The second electrode of the semiconductor component is formed of aluminum. Oxide films of aluminum on surfaces of both the second electrode and the metallic wire **18** are removed when the second electrode and the metallic wire are pressed into contact with each other with an ultrasonic energy being applied thereto in an ordinary temperature state. The second electrode and the metallic wire **18** are thus joined. The metallic wire **18** joined to the second electrode of the one semiconductor component is routed to the metallic lead **19** obtained by plating copper with tin, and is joined to the metallic lead **19** by performing a wedge bonding method.

Thereafter, for a purpose of physically protecting the one semiconductor component and the metallic wire **18**, and improving reliability, the semiconductor component **1** and the metallic wire **18** are coated and sealed with the sealing resin **5** by performing a transfer molding technique or injection molding technique. The metallic lead **19** is bent and cut by molds to be even with the metallic element **4**.

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During this sequence of procedures, an electronic component named "TO-220" comprising the one semiconductor component, the high temperature solder **3**, the metallic element **4**, the metallic wire **18**, the metallic lead **19** and the sealing resin **5** is completed.

After a solder paste is printed onto the metallic base circuit board **14**, various components such as the above electronic component "TO-220", the projecting connector **22**, and the like are placed on the metallic base circuit board. The metallic base circuit board **14** in its entirety is put into a heating furnace, whereby the solder paste is melted. The solder paste is then set by being returned to an ordinary temperature. This set solder **6** electrically and physically joins the metallic base circuit board **14** to various electronic components such as the electronic component "TO-220", the projecting connector **22**, and the like.

For providing electrical insulation, the sealing resin **24** is applied to the metallic base circuit board **14** in its entirety. The metallic base circuit board **14**, with the various electronic components, is put into a reduced pressure furnace to remove bubbles mixing inside the sealing resin **24**, and then put into a heating furnace to set the sealing resin **24**.

Next, the silicone grease **15** is applied to the heat radiation plate **10**. The metallic base circuit board **14** is brought into intimate contact with the heat radiation plate **10** and fixed by screws. Then, by inserting the projecting connector **22** into the dented connector **23** after registering the projecting connector **22** mounted on the metallic base circuit board **14** with the dented connector **23** mounted on the circuit board **7**, the circuit board **7** is brought into intimate contact with the projecting screw bed *10a* and fixed by screws **11**.

In the manner as above, the process of mounting to the metallic base circuit board **14** electronic components which include electronic components "TO-220" for switching a motor driving current and requiring heat radiation, and the process of combining the circuit board **7** including the circuit for controlling the electronic components "TO-220" and requiring no heat radiation, are completed.

The above-described arrangement generates a loss caused by a resistance of metallic wires **18** and metallic leads **19** and also a stray inductance because of a length of the wires **18** and leads **19**. In addition, for example, since the electronic component "TO-220" is equipped with a metallic lead **19**, a larger area than an area of the electronic component "TO-220" is required for the metallic base circuit board **14**, thereby impeding miniaturization and high-density mounting.

Meanwhile, a motor driving device for electric products alike has been required to be made compact and highly efficient in terms of heat radiation to meet a recent trend towards lighter, thinner, shorter and smaller construction of electric products. However, when bubbles are present inside the high temperature solder **3**, the bubbles obstruct heat transfer generated by a semiconductor component, thereby increasing a resistance from the semiconductor component to the metallic element **4**. As a result, only a bubble part becomes high in temperature, which leads to breakage of the semiconductor component **1** in a worst case.

As described hereinabove, the metallic wire **18** is joined to the second electrodes of semiconductor components by performing a wedge bonding method with the aluminum wire. In the conventional art, the metallic wire **18** is limited in thickness due to this joining method, and at the same time the metallic wire **18** is limited in length due to an arrangement of substrate electrodes, thereby making it impossible to reduce a wiring resistance. Coping with an on-state resis-

tance decrease in consequence of recent progress of semiconductor components is thus hindered, with an imposing problem of noise increase resulting from electrical signals' requirement of a high frequency and a large current.

SUMMARY OF THE INVENTION

The present invention is devised to solve the above problems and has for its essential object to provide an electronic circuit device which is compact, has good heat radiation efficiency and can reduce resistance and stray inductance, and provide a method for manufacturing the electronic circuit device.

In order to accomplish this objective, an electronic circuit device is provided according to a first aspect of the present invention, which comprises:

a semiconductor element requiring heat radiation and having electrodes formed on opposite faces thereof;

a first circuit board electrically connected via a metallic plate to a first electrode of the electrodes formed on one of the opposite faces of the semiconductor element, on which circuit board the metallic plate and the semiconductor element are placed;

a second circuit board arranged on a side of the other of the opposite faces of the semiconductor element so as to be opposite to the first circuit board, and having a control circuit for the semiconductor element; and

a metallic wire for directly electrically connecting to each other a second electrode, of the electrodes present on the other of the opposite faces, and the second circuit board.

The above metallic wire may be formed to include a first bend portion for absorbing expansion and contraction of the first circuit board and the second circuit board resulting from heat radiation of the semiconductor element.

The metallic wire joined to the second electrode may be extended in a thickness direction of the semiconductor element.

The electronic circuit device may be constituted to further include a heat radiation member with supporting members for receiving the first circuit board thereon and supporting the second circuit board. The metallic wire may be provided with a second bend portion for absorbing, in a state with the second circuit board being supported by the supporting members, expansion and contraction of the first circuit board and the second circuit board resulting from heat radiation, and for pressing the first circuit board against the heat radiation member.

An electronic circuit device of a power control system according to a second aspect of the present invention comprises:

a semiconductor element requiring heat radiation and having first electrodes and second electrodes respectively formed on opposite faces thereof;

bumps formed on the second electrodes; and

a metallic member having a first face arranged opposite to the first electrodes so as to be electrically connected to the first electrodes, and including installation members formed of a metal erected on the first face, along a thickness direction of the semiconductor element, to a height which exceeds a height of the bumps in the thickness direction when the semiconductor element with the bumps is placed on the first face.

Three or more installation members may be provided for one metallic member in the above electronic circuit device of the second aspect.

The electronic circuit device of the second aspect may further include a second circuit board which is arranged on a side opposite to that of the first electrodes so as to be electrically connected to the bumps and leading ends of the installation members, and is provided with a control circuit for the semiconductor element.

Also, the above electronic circuit device of the second aspect may further include a heat radiation member with supporting members for receiving the metallic member thereon via an electric insulating member, and dissipating heat conducted from the semiconductor element to the metallic member.

According to a third aspect of the present invention is provided a method for manufacturing an electronic circuit device having:

a semiconductor element requiring heat radiation and having first electrodes and second electrodes respectively formed on opposite faces thereof;

bumps formed on the second electrodes; and

a metallic member having a first face arranged opposite to the first electrodes so as to be electrically connected to the first electrodes, and including installation members formed of a metal erected on the first face, along a thickness direction of the semiconductor element, to a height which exceeds a height of the bumps in the thickness direction when the semiconductor element with the bumps is placed on the first face,

wherein the method comprises:

bringing the first face of the metallic member and the first electrodes into contact with each other, placing the semiconductor element on the first face, and heating the semiconductor element;

supplying a molten solder to the first face;

relatively pressing the semiconductor element and the metallic member to remove bubbles from inside the molten solder present between the first face and the first electrodes; and

decreasing a temperature of the molten solder while maintaining a pressing state, thereby solidifying the molten solder and joining the semiconductor element and the metallic member to each other.

In the manufacturing method of the third aspect, after joining of the semiconductor element and the metallic member, the method further includes a step of electrically connecting the bumps and leading ends of the installation members to a second circuit board which is arranged on a side of the other face and is provided with a control circuit for the semiconductor element,

wherein, when a plurality of the metallic members are attached to the second circuit board, heights of the installation members of the metallic members may be adjusted to unify all the metallic members in terms of height with respect to the second circuit board.

As described hereinabove, the electronic circuit device according to the first aspect of the the present invention is provided with the metallic wire for directly electrically connecting the second electrode formed on the other of the opposite faces of the semiconductor element and the second circuit board arranged on the side of the other opposite face. Since the conventional dented connector and projecting connector can be eliminated, the electronic circuit device can be made compact.

Moreover, when the metallic wire is provided with the bend portion, the bend portion can absorb expansion and contraction between the first circuit board and the second circuit board resulting from heat of the semiconductor element.

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Since the metallic wire is extended in the thickness direction of the semiconductor element, the electronic circuit device can furthermore be miniaturized.

When the metallic wire is extended in the thickness direction of the semiconductor element and is further provided with the second bend portion, not only miniaturizing the electronic circuit device and absorbing expansion and contraction can both be achieved, but the first circuit board can be pressed against the heat radiation plate, so that heat can be stably removed.

In the electronic circuit device according to the second aspect of the present invention, the semiconductor element is provided with the bumps on the second electrodes and metallic member having installation members, so that wiring lines are eliminated. Consequently, stray inductance and conduction resistance resulting from wiring lines can be reduced.

In the case where a plurality of the metallic members are provided, the height of the metallic members can be made uniform by being adjusted by the installation members.

Since the semiconductor element and the second circuit board can be directly electrically connected to each other by providing the metallic member, the conventional dented connector and projecting connector are eliminated, thus making the electronic circuit device small in size. When the heat radiation member is provided to support the second circuit board, heat from the metallic member can be stably dissipated by the one heat radiation member.

According to the manufacturing method for the electronic circuit device in the third aspect of the present invention, the solder between the semiconductor element and the metallic member is solidified after the semiconductor element and the metallic member are relatively pressed against each other so as to remove bubbles from inside the solder. Therefore, thermal conduction from the semiconductor element to the metallic member will not be obstructed by bubbles, thus being able to prevent an abnormal temperature rise of the semiconductor element.

BRIEF DESCRIPTION OF DRAWINGS

These and other objects and features of the present invention will become clear from the following description taken in conjunction with the preferred embodiments thereof with reference to the accompanying drawings in which:

FIG. 1 is a sectional view of a second circuit device as an electronic circuit device of a power control system according to a first embodiment of the present invention;

FIG. 2 is a diagram of semiconductor elements constituting a first circuit unit in FIG. 1;

FIG. 3 is a diagram showing a state with bumps formed on the semiconductor elements of FIG. 2;

FIG. 4 is a diagram showing a state in which the semiconductor elements with bumps shown in FIG. 3 are mounted to a metallic member;

FIG. 5 is a diagram of a state having a sealing resin further provided to the state of FIG. 4;

FIG. 6 is a sectional view of a state in which the first circuit unit of FIG. 5 is mounted to a second circuit board;

FIG. 7 is a sectional view of a state in which a plurality of the first circuit units are mounted to the second circuit board;

FIG. 8 is a sectional view of a second circuit device as an electronic circuit device of a power control system according to a second embodiment of the present invention;

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FIG. 9 is a sectional view of a modified example of the second circuit device of FIG. 8;

FIG. 10 is a sectional view of a second circuit device as an electronic circuit device of a power control system according to a third embodiment of the present invention;

FIG. 11 is a sectional view of a modified example of the second circuit device of FIG. 10;

FIG. 12 is a sectional view of a second circuit device as an electronic circuit device of a power control system according to a fourth embodiment of the present invention;

FIG. 13 is a sectional view of a modified example of the second circuit device of FIG. 12;

FIG. 14 is a sectional view of a second circuit device as an electronic circuit device of a power control system according to a fifth embodiment of the present invention;

FIG. 15 is a sectional view of a modified example of the second circuit device of FIG. 14; and

FIG. 16 is a sectional view of a conventional electronic circuit device of a power control system.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

Before description of the present invention proceeds, it is to be noted that like parts are designated by like reference numerals throughout the accompanying drawings.

Electronic circuit devices according to the preferred embodiments of the present invention and a method for manufacturing the electronic circuit devices will be described below with reference to the drawings.

First Embodiment

FIG. 5 shows a first electronic circuit device of a power control system (referred to as "a first circuit unit" hereinbelow) **100** which is one example of an electronic circuit device of this embodiment. FIG. 1 shows a second electronic device of a power control system (referred to as "a second circuit device" below) **101** including first circuit units **100**, which corresponds to another example of an electronic circuit device.

The second circuit device **101** of FIG. 1 is constituted as follows. **111** is a drive semiconductor element which is used in a control system for controlling a driving current to a driving device, e.g., a motor or the like and which requires a heat radiation treatment. The drive semiconductor element includes an IGBT (Insulated Gate Bipolar Transistor) **111-1** and a diode **111-2**. As shown in FIG. 3, the drive semiconductor element **111** has a first electrode **111c** and second electrodes **111d** formed on opposite faces **111a** and **111b**, respectively. **112** are bumps (projecting electrodes) formed on the second electrodes **111d** of the drive semiconductor element **111**. **114** is a metallic member which radiates and diffuses heat generated from the drive semiconductor element **111** as shown in FIG. 4. An entire surface of the metallic member **114** is plated with tin after projecting parts corresponding to installation members **114b**, to be described later, are formed from copper as a base material with use of molds. The metallic member **114** has a first face **114a**, arranged opposite to the first electrode **111c**, to be electrically connected to the first electrode **111c**. **113** is a high temperature solder for joining the first electrode **111c** of the drive semiconductor element **111** and the first face **114a** of the metallic member **114** to each other. The aforementioned installation members **114b** are projected from the first face **114a** parallel to a thickness direction **111e** of the drive semiconductor element **111**, and have a height to exceed the bumps **112** in the thickness direction **111e** when the drive

semiconductor element **111**, with the bumps **112** thereon, is placed onto the first face **114a**. Although the installation members **114b** of a pair are formed in the embodiment, three or more installation members can be formed for one first circuit unit **100**. If three or more installation members are formed, a flatness of the first circuit unit **100**, when mounted to a second circuit board **116**, can be further improved as will be described later.

As indicated in FIG. 5, **115** is a sealing resin for protecting the drive semiconductor element **111** and the bumps **112**, which is applied to the drive semiconductor element **111**, mounted together with the bumps **112**, to the first face **114a** to such a level that nearly half a height of the bump **112** is exposed in the thickness direction **111e**. The first circuit unit **100** is constituted in the above-described manner.

As is shown in FIG. 6, the first circuit unit **100** is electrically connected, with the bumps **112** and leading ends **114c** of the installation members **114b**, through a solder **117** applied thereto to the second circuit board **116** arranged at a side of the face **111b** of the drive semiconductor element **111**.

As shown in FIG. 1, the second circuit board **116** includes a control circuit for the drive semiconductor element **111**, with passive electronic components **122**, such as a capacitor, a resistor and the like, and active electronic components **123**, such as a transistor, a memory, and the like, constituting the control circuit mounted to one face or to both faces of the second circuit board. Internal wirings **124** are provided in the second circuit board **116** to electrically connect the electronic components **122** and **123** to the drive semiconductor element **111**.

A heat radiation member **120**, on which the metallic member **114** is placed, dissipates heat transferred from the drive semiconductor element **111** to the metallic member **114** into surrounding air. The heat radiation member **120** also has, for instance, a recessed part **120b** as shown in FIG. 1 formed by supporting members **120a** which support the second circuit board **116**. The first circuit unit **100** is stored in the recessed part **120b**, and both end parts of the second circuit board **116** are fixed by screws **121** to the pair of the supporting members **120a**. An insulating resin **119** of a high heat dissipation efficiency is applied, by performing a heat press method, to a bottom face **120c** of the recessed part **120b** so as to conduct heat from the metallic member **114** to the heat radiation member **120**, and at the same time electrically insulate the metallic member **114** and the heat radiation member **120** from each other. Moreover, a silicone grease **118** is filled between the insulating resin **119** and the metallic member **114** to decrease heat resistance at a contact portion between the metallic member **114** and the insulating resin **119**. Since a height of the metallic member **114** is specified as will be discussed later, the silicone grease **118** works as a buffer to press the metallic member **114** towards the insulating resin **119**, thereby bringing the metallic member **114** and the insulating resin **119** into intimate contact with each other at all times. A soft sheet may be used in place of the silicon grease **118**.

The second circuit device **101** is constituted as above.

A process of forming the above first circuit unit **100** will be described with reference to FIGS. 2-6.

Referring to FIG. 3, gold plating bumps **112** are formed on second aluminum electrodes **111d** of the drive semiconductor element **111** of FIG. 2 with use of a projecting electrode forming machine which is an improved wire bonding apparatus, or with use of plating. Then as shown in FIG. 4, in a state in which the drive semiconductor element **111** is placed at a predetermined position on the first face **114a** of

the metallic member **114**, the drive semiconductor element **111** and the metallic member **114** are put into a high temperature furnace heated to 350° C., in which a reducing atmospheric state in a mixed atmosphere of nitrogen and hydrogen is maintained. Molten high temperature solder **113** is supplied, specifically by being dropped according to the embodiment, onto the first face **114a** of the metallic member **114** in the high temperature furnace. As a consequence, the first face **114a** of the metallic member **114** and the first electrode **111c** of the drive semiconductor element **111** are joined by the high temperature solder **113**.

After the high temperature solder **113** is supplied, the drive semiconductor element **111** and the metallic member **114** are relatively pressed against each other to remove bubbles from inside the molten solder present between the first face **114a** and the first electrode **111c**. The metallic member **114** is pressed parallel to the drive semiconductor element **111** so as to bring the metallic member **114** into intimate contact with the drive semiconductor element **111**. With an absolute contact state maintained, the metallic member **114** and the drive semiconductor element **111** are cooled to solidify the solder **113**. The metallic member **114** and the drive semiconductor element **111** are returned to air after this solidification.

Next in FIG. 5, the sealing resin **115** is formed to mechanically protect the drive semiconductor element **111** itself and joining portions between the drive semiconductor element **111** and the bumps **112**. The sealing resin **115** is applied in a liquid state and set by heating, or formed by a transfer molding or an injection molding technique. The first circuit unit **100** is formed during this process.

Subsequently, for protecting the drive semiconductor element **111** and enabling the drive semiconductor element **111** to be handled as an electronic component, the first circuit unit **100** is joined simultaneously to the electronic components **122** and **123** on the second circuit board **116** with use of the solder **117** as shown in FIG. 6. A normally used surface mounting technique (SMT) is employed for this joining.

In the present embodiment as discussed hereinabove, the metallic member **114** is provided with installation members **114b** of metal which project from the first face **114a** of the metallic member **114** in the thickness direction **111e** of the drive semiconductor element **111**. Accordingly, an electric connection between the first electrodes **111c** of the drive semiconductor element **111** and the second circuit board **116** can be achieved through the installation members **114b**, and moreover, the metallic member **114** with the drive semiconductor element **111** can be fixed to the second circuit board **116** through the installation members **114b**. Since a conventionally required dented connector **23** and projecting connector **22** are hence eliminated, the first circuit unit **100** and the second circuit device **101** can be made compact in size. At the same time, since the second electrodes **111d** of the drive semiconductor element **111** are electrically connected to the second circuit board **116** via the bumps **112**, a stray capacity can be reduced in comparison with conventional art which uses metallic wires **18** and metallic leads **19**, and a resistance can be decreased.

Since wiring resistance is reduced by this joining via the bumps **112** as compared with the conventional art, reduction of on-state resistance and noise is enabled.

As above, bubbles are removed from inside the solder **113** by relatively pressing the first electrode **111c** of the drive semiconductor element **111** and the metallic member **114** against each other to join the same. Thus, the drive semiconductor element **111** is prevented from abnormally overheating because of voids.

FIG. 7 shows a state in which a plurality of first circuit units **100** are joined to the second circuit board **116** upon completion of procedures in FIGS. 2-5. Although two first circuit units **100** are installed in FIG. 7, needless to say, there may be installed three or more units, or in contrast one unit may be installed. In a case where the plurality of the first circuit units **100** are installed, an error range of heights **H1** and **H2** of the first circuit units **100**, as measured from the second circuit board **116**, should be maintained within a specified value. While the metallic member **114** has the installation members **114b**, a height of the installation members **114b** of each of the metallic members **114** can be adjusted by, e.g., cutting the installation members **114b**, whereby a positional accuracy with an error range of within $\pm 50 \mu\text{m}$ can be realized for the heights **H1** and **H2**.

The second circuit device **101** shown in FIG. 1 is a combination of the second circuit board **116**, in a state of FIG. 7, and the heat radiation member **120**. The second circuit device **101** naturally exerts the same effects as those of the first circuit unit **100**.

Second Embodiment

A fourth circuit device **103** as a modified example of the second circuit device **101** will be described with reference to FIG. 8.

The fourth circuit device **103** includes a third circuit unit **102** which is a modified example of the above first circuit unit **100**. Reference numeral **133** of FIG. 8 indicates a first circuit board formed of a metal. Single-sided surface mounting is performed for the second circuit board **116** in FIG. 8.

The third circuit unit **102** has spring wires **136** of a metal and a second metallic member **134** respectively attached in place of the bumps **112** and the metallic member **114** of the first circuit unit **100**. Each spring wire **136** is a conductor for electrically connecting the drive semiconductor element **111** and the second circuit board **116** to each other, and has a second bend portion **136a** as indicated in FIG. 8. In the fourth circuit device **103** of FIG. 8, one end of each spring wire **136** penetrating the second circuit board **116** is soldered to the second circuit board **116**. The second metallic member **134** has no installation member **114b**. The second bend portion **136a** of each spring wire **136** is not resin sealed by sealing resin **115**.

The third circuit unit **102** is constituted the same in other points as the above-described first circuit unit **100**.

The third circuit unit **102** of the above constitution has the second metallic member **134** joined to the first circuit board **133** by solder **117**. The first circuit board **133** is placed on heat radiation member **120** via silicone grease **118**.

In the fourth circuit device **103** constituted as above, the first circuit board **133** can be pressed by the second bend portions **136a** of the spring wires **136** to the heat radiation member **120**, and moreover, a thermal stress can be absorbed by the spring wires **136**, so that a high reliability is realized.

Since each of the spring wires **136** is arranged parallel to thickness direction **111e** and is not directed orthogonally to the thickness direction **111e** as illustrated, the fourth circuit device **103** is made compact. Furthermore, since bubbles present in solder **113** between drive semiconductor element **111** and the second metallic member **134** are eliminated, the drive semiconductor element **111** can be prevented from abnormally overheating because of voids.

A fourth circuit device **103-1** shown in FIG. 9 is a modification of the fourth circuit device **103** of FIG. 8, in which spring wires **136-1** are soldered to one face of second circuit board **116** without penetrating the second circuit board **116** as shown in FIG. 9. Double-sided mounting is provided for the second circuit board **116**. This modified

fourth circuit device **103-1** is of the same constitution in other points as the above-described fourth circuit device **103** indicated in FIG. 8.

The same effects as in the fourth circuit device **103** in FIG. 8 can also be obtained in the fourth circuit device **103-1** of FIG. 9.

Third Embodiment

A fifth circuit device **104** as a modified example of the second circuit device **101** will be depicted with reference to FIG. 10.

The fifth circuit device **104** has a constitution such that the projecting connector **22** and the dented connector **23** are removed from the driving device described with reference to FIG. 16, and a fresh metallic lead **139** is connected to metallic wire **18**. Operation of removing bubbles described above is performed during soldering to join drive semiconductor element **111** and second metallic member **134** to one another. Single-sided surface mounting is provided for the second circuit board **116** in FIG. 8.

The metallic lead **139** is a metal wire having tin plating on copper, which is joined to aluminum metallic wire **18** subjected to wedge bonding of aluminum. A first bend portion **139a** is formed in a halfway portion of the metallic lead **139**. One end of the metallic lead **139** is soldered after passing through the second circuit board **116**. Double-sided mounting is performed for the second circuit board **116**.

Since the projecting connector **22** and the dented connector **23** are eliminated and the metallic lead **139** is directly connected to the second circuit board **116**, the fifth circuit device **104** can be made compact. The first bend portion **139a** formed in the metallic lead **139** can absorb thermal stress, thereby realizing a high reliability. Further, since bubbles are removed from inside solder **113** present between the drive semiconductor element **111** and the second metallic member **134**, the drive semiconductor element **111** can be prevented from abnormally overheating due to voids.

A fifth circuit device **104-1** in FIG. 11 is a modification of the fifth circuit device **104** of FIG. 10. A metallic lead **139-1** is, as shown in FIG. 11, soldered to one face of second circuit board **116** without penetrating the second circuit board **116**. The constitution of the fifth circuit device **104-1** in other points is the same as that of the above-described fifth circuit device **104** shown in FIG. 10.

The fifth circuit device **104-1** can obtain the same effects as in the fifth circuit device **104** shown in FIG. 10.

Fourth Embodiment

A sixth circuit device **105** as a modified example of the above fourth circuit device **103** will be described below with reference to FIG. 12.

The sixth circuit device **105** is provided with metallic wires **141** in place of the spring wires **136** in the fourth circuit device **103**. Each metallic wire **141** has a gold ball **140** formed by melting a gold wire by using an electric spark. Each gold ball **140** is joined to drive semiconductor element **111** or the like. Joining of the gold balls **140** is executed by performing a wire bonding technique through heating and ultrasonically vibrating the gold wires. After this joining, each metallic wire **141** is pulled up in a thickness direction **111e**, cut to a predetermined length and sealed by the sealing resin **115** to be prevented from deformation. One end of each metallic wire **141** passing through the second circuit board **116** is soldered. The constitution of other points of the sixth circuit device is the same as that of the fourth circuit device **103** described earlier and shown in FIG. 8.

According to the sixth circuit device **105**, similar to the fourth circuit device **103**, since the metallic wires **141** extend in the thickness direction **111e**, the sixth circuit device **105**

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can be made compact. Moreover, since bubbles are removed from inside solder 113 present between the drive semiconductor element 111 and second metallic member 134, the drive semiconductor element 111 can be prevented from abnormal overheating because of voids.

A sixth circuit device 105-1 in FIG. 13 is a modification of the sixth circuit device 105 in FIG. 12, wherein metallic wires 141-1 are soldered to one face of second circuit board 116 without being passed through the second circuit board 116, as is clear from FIG. 13. The sixth circuit device 105-1 is constituted the same in other points as is the sixth circuit device 105 described above.

The sixth circuit device 105-1 of FIG. 13 can obtain the same effects as the effects of the sixth circuit device of FIG. 12.

Fifth Embodiment

Referring to FIG. 14, a seventh circuit device 106 as a modified example of the fourth circuit device 103 will be depicted herein.

The seventh circuit device 106 uses metallic wires 142 of, e.g., aluminum or copper. The metallic wires 142 are joined to drive semiconductor element 111 or the like by performing a wedge bonding technique with ultrasonic vibration applied. Each metallic wire 142 after being so joined is pulled up in a thickness direction 111e, cut to a predetermined length and sealed by sealing resin 115 to be prevented from deformation. One end of each metallic wire 142, penetrating through second circuit board 116, is soldered. The seventh circuit device 106 is constructed the same in other points as the above-described fourth circuit device 103 shown in FIG. 8.

According to the seventh circuit device 106, similar to the fourth circuit device 103, since the metallic wires 142 extend in the thickness direction 111e, the seventh circuit device 106 can be formed compact in size. Also, since aluminum or copper is used for the metallic wires 142, the seventh circuit, device 106 can be constructed inexpensively as compared with the case of using gold wires. Additionally, a process of removing bubbles prevents the drive semiconductor element 111 from being abnormally overheated.

The seventh circuit device 106 in FIG. 14 is modified by way of example to a seventh circuit device 106-1 shown in FIG. 15. As indicated in FIG. 15, metallic wires 142-1 are soldered to one face of second circuit board 116 without penetrating the second circuit board. The modified seventh circuit device 106-1 is of the same constitution in other points as the aforementioned seventh circuit device 106.

The seventh circuit device 106-1 of FIG. 14 can obtain the same effects as the seventh circuit device 106 shown in FIG. 13.

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Although the present invention has been fully described in connection with the preferred embodiments thereof with reference to the accompanying drawings, it is to be noted that various changes and modifications are apparent to those skilled in the art. Such changes and modifications are to be understood as included within the scope of the present invention as defined by the appended claims unless they depart therefrom.

What is claimed is:

1. An electronic circuit device comprising:
 - a semiconductor element having a first surface and a second surface, with said first and second surfaces facing in opposite directions;
 - a first electrode on said first surface;
 - a second electrode on said second surface;
 - a bump on said second electrode;
 - a metallic member having metal installation members extending from a first face of said metallic member; and
 - a circuit board electrically connected to said bump and to leading end parts of said metal installation members, said circuit board having a control circuit for said semiconductor element,
 wherein said first face of said metallic member is electrically connected to said first electrode such that said metal installation members extend from said first face to a level beyond a level at which said bump is positioned.
2. The electronic circuit device according to claim 1, wherein said semiconductor element requires heat radiation therefrom, and further comprising:
 - a heat radiation member connected to said metallic member via an electric insulating member, said heat radiation member for dissipating heat from said semiconductor element to said metallic member.
3. The electronic circuit device according to claim 2, wherein said heat radiation member includes supporting members.
4. The electronic circuit device according to claim 3, wherein said circuit board is connected to said supporting members.
5. The electronic circuit device according to claim 4, wherein said metallic member is between supporting members.
6. The electronic circuit device according to claim 3, wherein said metallic member is between said supporting members.

* * * * *

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 6,943,443 B2
DATED : September 13, 2005
INVENTOR(S) : Kazuhiro Nobori et al.

Page 1 of 1

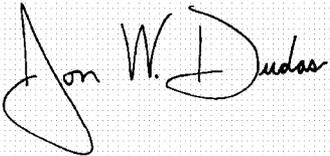
It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Column 12.

Line 43, replace "between supporting members." with -- between said supporting members. --.

Signed and Sealed this

Twenty-eighth Day of March, 2006

A handwritten signature in black ink on a light gray dotted background. The signature reads "Jon W. Dudas" in a cursive style. The "J" is large and loops around the "on". The "W" and "D" are also prominent.

JON W. DUDAS

Director of the United States Patent and Trademark Office